Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/994,173	YOON ET AL.	
Examiner	Art Unit	
Charles Kim	2623	

	SEAR	CHED	
Class	Subclass	Date	Examiner
382	115-127	4/29/2005	СК
356	71	4/29/2005	ск
340	5.52,5.53	4/29/2005	ск
340	5.8-5.83	4/29/2005	ск
902	3,5	4/29/2005	ск

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
382	125	4/29/2005	СК	
340	5.83	4/29/2005	ск	
902	3	4/29/2005	ск	

SEA (INCLUDING)	RCH NOT SEARCH	ES STRATEGY	)
		DATE	EXMR
EAST		4/29/2005	ск